

Search Notes**Application/Control No.**

09/936,727

Examiner

Krista M. Flanagan

Applicant(s)/Patent under Reexamination

MIYOSHI ET AL.

Art Unit

2631

SEARCHED

Class	Subclass	Date	Examiner
375	144, 148, 346	12/2/2004	KMF
370	286,342	12/2/2004	KMF
370	441	12/2/2004	KMF
375	130,142	12/10/2004	KMF
375	147,150	12/10/2004	KMF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East [(signal data symbol pulse) same (replica\$3 copy) same (cancel\$3 remove\$3) near5 (interference\$3 noise) and despread\$3]	12/2/2004	KMF
Inventorship	11/17/2004	KMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner